IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

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In re patent application of: PE)	
70 %)	Before the Examiner
Henning Groll et al.)	NT 4 37.4 A
\ . ak/)	Not Yet Assigned
Serial No. 10/688,312)	Group Art Unit 1743
Filed October 17, 2003)	-
)	
SYSTEM AND METHOD FOR)	
ANALYTE MEASUREMENT USING)	
AC PHASE ANGLE MEASUREMENT)	February 10, 2005

INFORMATION DISCLOSURE STATEMENT

MAIL STOP AMENDMENT Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

Pursuant to the duty of disclosure in accordance with 37 C.F.R. §1.56, Applicant wishes to bring to the attention of the Examiner the items of information listed on the enclosed Information Disclosure Citation Form. This information has not been previously submitted in this application, and has not been heretofore cited previously by the Examiner. Copies of all foreign patent documents and non-patent literature are enclosed in accordance with 37 CFR 1.98(a). Copies of cited U.S. patents and patent applications are not enclosed pursuant to 37

CFR 1.491(b).

I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to the Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450 on February 10, 2005 Date of Deposit Troy J. Cole Name of Registered Representative Signature February 10, 2005 Date of Signature

For items of information contained in this Statement that are not in the English language, under §1.98(a)(3)(i) these items are understood to be relevant in that they relate to biosensors and were included in the results of searches conducted on behalf of Applicants.

The filing of this Information Disclosure Statement shall not be construed as an admission that the information cited is, or is considered to be, material to patentability as defined in §1.56(b).

This Statement is being submitted prior to the mailing of any Office Action on the merits. It is believed that no fee is required for consideration of the submitted items. However, should any fees be deemed required, the Commissioner is authorized to charge such fees to Deposit Account No. 23-3030, but is not to include payment of issue fees.

Respectfully submitted

By:

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Substitute for form 1449A/PTO

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(use as many sheets as necessary)

of

Complete if Known 10/688,312 **Application Number** Filing Date October 17, 2003 David W. BURKE First Named Inventor 1743 **Group Art Unit Examiner Name** Attornev Docket Number 7404-554

	U.S. PATENT DOCUMENTS						
Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear		
		3,526,480	09/01/1970	Findl et al.			
		3,551,295	12/29/1970	Dyer			
		3,621,381	11/16/1971	Eckfeldt			
		3,715,192	02/06/1973	Wenz et al.			
		3,720,093	03/13/1973	Gill			
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		3,838,033	09/24/1974	Mindt et al.			
		3,902,970	09/02/1975	Levin			
		3,919,627	11/11/1975	Allen			
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		3,980,437	09/14/1976	Kishimoto et al.			
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		4,008,448	02/15/1977	Muggli			
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		4,053,381	10/11/1977	Hamblen et al.			

Examiner	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	T⁴
Initials* No. ¹	No.1	Country Code ³ -Number ⁴ -Kind Code ⁸ (if known)	MM-DD-YYYY	Document	Figures Appear	
		AU 737 787	08/30/2001	Batman et al.		
		DE 36 43 263	07/07/1988	Hommel Host		
		DE 40 11 428 A1	11/29/1990	Kühn et al.		
		DE 298 14 997 U1	08/03/1993	LRE		
		DE 199 36 693	02/08/2001	LRE		
		EP 0 010 456	04/30/1980	Columbus		
		EP 0 034 049	08/19/1981	Columbus		
		EP 0 057 110	08/04/1982	Columbus		

Examiner Signature	Date Considered	

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹ Applicant's unique citation designation number (optional). ² See Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the emperor must precede the serial number of the patent document. ³ Kind of document by the apopropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. ⁶ Applicant is to place a check mark here if English language Translation is attached.

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Substitute for form 1449A/PTO				Complete if Known			
				Application Number	10/688,312		
	RMATION			Filing Date	October 17, 2003		
STA	TEMENT B	Y AP	PLICANT	First Named Inventor	David W. BURKE		
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Sheet	2	of	38	Attornev Docket Number	7404-554		

			U.S. PATEN	T DOCUMENTS	
Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear
		4,065,263	12/27/1977	Woodbridge, III	
		4,086,631	04/25/1978	Vick	
		4,123,701	10/31/1978	Josefsen et al.	
		4,127,448	11/28/1978	Schick et al.	
		4,184,936	01/22/1980	Paul et al.	
		4,214,968	07/29/1980	Battaglia et al.	
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		4,225,410	09/30/1980	Pace	
		4,230,537	10/28/1980	Delente et al.	
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		4,260,680	04/07/1981	Muramatsu et al.	
		4,263,343	04/21/1981	Kim	
		4,265,250	05/05/1981	Parker	
		4,273,134	06/16/1981	Ricciardelli	
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		4,297,569	10/27/1981	Flies	
		4,301,412	11/17/1981	Hill et al.	

Examiner Cite Initials* No.1	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	T⁵
	No.¹	Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	MM-DD-YYYY	Document	Figures Appear	
		EP 0 073 056 A2	03/02/1983	Van		
		EP 0 084 874 A1	08/03/1983	Klesewetter		
		EP 0 101 880	03/07/1984	Preidel et al.		
		EP 0 127 958 B2	04/10/1996	Higgins et al.		
		EP 0 132 790 A2	02/13/1985	Kasielke et al.		
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		EP 0 171 148	02/12/1986	Shanks et al.		
		EP 0 171 239	02/12/1986	Ikeda et al.		

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				Application Number	10/688,312		
INF	ORMATION	DISC	CLOSURE	Filing Date	October 17, 2003		
ST	ATEMENT B	Y AP	PLICANT	First Named Inventor	David W. BURKE		
,				Group Art Unit	1743		
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Sheet	3	of	38	Attornev Docket Number	7404-554		

			U.S. PATEN	T DOCUMENTS	
Examiner Initials*	Cite No. [†]	Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear
		4,303,887	12/01/1981	Hill et al.	
_		4,323,536	04/06/1982	Columbus	
		4,329,642	05/11/1982	Luthi et al.	
		4,366,033	12/28/1982	Richter et al.	
		4,407,290	10/04/1983	Wilber	
		4,407,959	10/04/1983	Tsuji et al.	
		4,413,407	11/08/1983	Columbus	
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_		4,431,004	02/14/1984	Bessman et al.	
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		4,477,314	10/16/1984	Richter et al.	
		4,477,575	10/16/1984	Vogel et al.	
		4,499,423	02/12/1985	Matthiessen	
		4,510,383	04/09/1985	Ruppender	
		4,517,291	05/14/1985	Seago	

	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	T*
Initials*	No.¹	Country Code ³ -Number ⁴ -Kind Code ⁸ (if known)	MM-DD-YYYY	Document	Figures Appear	
		EP 0 186 286	07/02/1986	Nylander et al.		
		EP 0 206 218 B1	06/03/1991	Wogoman		
	-	EP 0 213 343 B2	02/01/1995	Young et al.		
		EP 0 230 472 B2	12/13/2000	Nankai et al.		
		EP 0 241 309 A2	10/14/1987	Walton et al.		
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		EP 0 255 291 B1	06/24/1992	Birch et al.		
		EP 0 287 883	10/26/1988	Blatt		

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Substitute for form 1449A/PTO				Complete if Known			
Substitute	10110m 1449A	VPIO		Application Number	10/688,312	-	
	ORMATION			Filing Date	October 17, 2003		
STA	TEMENT E	BY APF	PLICANT	First Named Inventor	David W. BURKE	-	
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Sheet	4	of	38	Attornev Docket Number	7404-554		

	U.S. PATENT DOCUMENTS							
Examiner Initials*	Cite No.1	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant			
initials* No.	Number-Kind Code ² (If known)			Figures Appear				
		4,545,382	10/08/1985	Higgins et al.				
		4,547,735	10/15/1985	Kiesewetter et al.				
		4,552,458	11/12/1985	Lowne				
		4,571,292	02/18/1986	Liu et al.				
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		4,682,602	07/28/1987	Prohaska				
		4,686,479	08/11/1987	Young et al.				
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		4,703,756	11/03/1987	Gough et al.				

Examiner	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	די
Initials*	No.1	Country Code ³ -Number ⁴ -Kind Code ⁶ (if known)	MM-DD-YYYY	Document	Figures Appear	
		EP 0 359 831	03/28/1990	Nankai et al.		
		EP 0 383 322 B1	02/05/1997	Seshimoto et al.		
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		EP 0 537 761 A3	02/02/1994	Yoshioka et al.		

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Examiner Signature	Date Considered	

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Substitute for form 1449A/PTO				Complete if Known			
				Application Number	10/688,312		
	ORMATION I			Filing Date	October 17, 2003		
STA	ATEMENT BY	Y AP	PLICANT	First Named Inventor	David W. BURKE		
		·		Group Art Unit	1743		
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Sheet	5	of	38	Attornev Docket Number	7404-554		

	U.S. PATENT DOCUMENTS								
Examiner Initials*	Cite No.1	Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear				
		4,711,245	12/08/1987	Higgins et al.					
		4,713,347	12/15/1987	Mitchell et al.					
		4,714,874	12/22/1987	Morris et al.					
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	-	4,816,224	03/28/1989	Vogel et al.					
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		4,820,636	04/11/1989	Hill et al.					
		4,832,814	05/23/1989	Root					

Examiner	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	T ⁶
Initials*	No.¹	Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	MM-DD-YYYY	Document	Figures Appear	
		EP 0 537 761 B1	08/27/1997	Yoshioka et al.		
		EP 0 546 536	06/16/1993	Yenoyama et al.		
		EP 0 636 880 A2	02/01/1995	Nankai et al.		
		EP 0 640 832	03/01/1995	Hughes Aircraft		
		EP 0 651 250 A2	05/03/1995	Hyodo et al.		
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		EP 0 732 590 A2	09/18/1996	Charlton et al.		
		EP 0 741 186 B1	10/17/2001	Genshaw et al.		

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Substitute for form 1449A/PTO				Complete if Known			
				Application Number	10/688,312		
INF	ORMATION	DISC	LOSURE	Filing Date	October 17, 2003		
STA	TEMENT B	Y AP	PLICANT	First Named Inventor	David W. BURKE		
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	U.S. PATENT DOCUMENTS						
Examiner Initials*		Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear		
		4,834,234	05/30/1989	Sacherer et al.			
		4,849,330	07/18/1989	Humphries et al.			
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		4,975,647	12/04/1990	Downer et al.			

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Initials*	No.¹	Country Code ³ -Number ⁴ -Kind Code ⁸ (if known)	MM-DD-YYYY	Document	Figures Appear	
		EP 0 837 320 A3	12/301998	Howard, III		
		EP 0 840 122 A2	05/06/1998	Charlton et al.		
		EP 0 851 224	07/01/1998	Ikeda et al.		
		EP 0 859 230	08/19/1998	Setford		
		EP 0 876 506	07/09/2003	Henning et al.		
		EP 0 878 713	11/18/1998	Bayer AG		
		EP 0 887 421 A1	12/30/1998	Matzinger et al.		
		EP 0 894 509 A2	02/03/1999	Herman		

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Substitut	e for form 1449AVF	-10		Application Number	10/688,312			
INF	ORMATION	DISC	CLOSURE	Filing Date	October 17, 2003			
ST	ATEMENT B	Y AP	PLICANT	First Named Inventor	David W. BURKE			
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Sheet	7	of	38	Attornev Docket Number	7404-554			

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		4,976,724	12/11/1990	Nieto et al.		
		4,999,582	03/12/1991	Parks et al.		
		4,999,632	03/12/1991	Parks		
	•	5,018,164	05/21/1991	Brewer et al.		
	-	5,019,974	05/28/1991	Beckers		
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		5,075,077	12/24/1991	Durley, III et al.	-	
		5,096,669	03/17/1992	Lauks et al.	-	
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		5,118,183	06/02/1992	Cargill et al.		
		5,120,420	06/09/1992	Nankai et al.		
		5,122,244	06/16/1992	Hoenes et al.		

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Initials*	No.1	Country Code ³ -Number ⁴ -Kind Code ⁶ (if known)	MM-DD-YYYY	Document	Figures Appear	
		EP 0 942 278 A2	09/15/1999	Kim et al.		
		EP 0 958 495	11/13/2002	Heller et al.		
		EP 0 964 059	12/15/1999	Ikeda et al.		
		EP 0 987 544	03/22/2000	Ikeda et al.		
		EP 1 009 850 B1	03/05/2003	Hughes et al.		
		EP 1 024 358 A1	08/02/2000	Kawanaka et al.		
		EP 1 035 216 A1	09/13/2000	Sang et al.		
		EP 1 067 384 A2	01/10/2001	Ohara et al.		

Examiner Signature	Date Considered	

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Applicant's unique citation designation number (optional). ¹ See Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the emperor must precede the serial number of the patent document. ³ Kind of document by the apOpropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. ⁶ Applicant is to place a check mark here if English language Translation is attached. here if English language Translation is attached.

Substitute for form 1449A/PTO				Complete if Known			
Substitute for form 1449APTO				Application Number	10/688,312		
INF	ORMATION I	DISC	CLOSURE	Filing Date	October 17, 2003		
ST	STATEMENT BY APPLICANT			First Named Inventor	David W. BURKE		
				Group Art Unit	1743		
(,	use as many sheet	is as i	necessary)	Examiner Name			
Sheet	8	of	38	Attornev Docket Number	7404-554		

_			U.S. PATEN	T DOCUMENTS	
Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear
		5,126,952	06/30/1992	Kildal-Brandt et al.	
		5,128,015	07/07/1992	Szuminsky et al.	
		5,141,850	08/25/1992	Cole et al.	
		5,141,868	08/25/1992	Shanks et al.	
		5,143,694	09/01/1992	Schafer et al.	
		5,179,005	01/12/1993	Phillips et al.	
·		5,179,288	01/12/1993	Miffitt et al.	
		5,182,707	01/26/1993	Cooper et al.	
		5,187,100	02/16/1993	Matzinger et al.	
		5,192,415	03/09/1993	Yoshioka et al.	
		5,220,920	06/22/1993	Gharib	
		5,232,516	08/03/1993	Hed	
		5,232,668	08/03/1993	Grant et al.	
		5,234,813	08/10/1993	McGeehan et al.	
		5,243,516	09/07/1993	White	
		5,246,858	09/21/1993	Arbuckle et al.	
		5,250,439	10/05/1993	Musho et al.	
		5,264,103	11/23/1993	Yoshioka et al.	
***		5,266,179	11/30/1993	Nankai et al.	

Examiner	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	Τ°
Initials*	No.¹	Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	MM-DD-YYYY	Document	Figures Appear	<u> </u>
		EP 1 074 832 A1	02/07/2001	Musho et al.		
		EP 1 081 490 A1	03/07/2001	Iketaki et al.		
		EP 1 102 991 B1	11/13/2002	Wong et al.		
		EP 1 119 637	03/24/2004	Feldman et al.		
		EP 1 129 211 B1	07/09/2003	Yon Hin et al.		
		EP 1 130 390 A1	09/05/2001	Tsuji et al.		
		EP 1 143 245	10/10/2001	Roche		

		
Examiner Signature	Date Considered	

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Substitute for form 1449A/PTO				Complete if Known			
				Application Number	10/688,312		
	ORMATION	_		Filing Date	October 17, 2003		
STA	ATEMENT BY	Y AP	PLICANT	First Named Inventor	David W. BURKE		
				Group Art Unit	1743		
(u	use as many shee	ets as n	ecessary)	Examiner Name			
Sheet	9	of	38	Attornev Docket Number	7404-554		

	U.S. PATENT DOCUMENTS								
Examiner Cite Initials* No.1		Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear				
		5,269,891	12/14/1993	Colin					
		5,279,294	01/18/1994	Anderson et al.					
	-	5,281,395	01/25/1994	Markart et al.					
		5,284,770	02/08/1994	Adrian et al.					
		5,286,362	02/15/1994	Hoenes et al.					
		5,288,636	02/22/1994	Pollmann et al.					
		5,296,192	03/22/1994	Carroll et al.					
		5,304,468	04/19/1994	Phillips et al.					
	,	5,306,623	04/26/1994	Kiser					
		5,311,426	05/10/1994	Donohue et al.					
		5,312,762	05/17/1994	Guiseppi-Elie					
		5,344,754	09/06/1994	Zweig					
		5,352,351	10/04/1994	White et al.					
		5,353,351	10/04/1994	Bartoli et al.					
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		5,371,687	12/06/1994	Holmes, II et al.					
		5,376,254	12/27/1994	Fisher					
		5,379,214	01/03/1995	Arbuckle et al.					

Examiner	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	4
Initials*	No.¹	Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	MM-DD-YYYY	Document	Figures Appear	
		EP 1 147 739 A2	10/24/2001	Essenpreis et al.		
		EP 1 152 239 A1	11/07/2001	Miyazaki et al.		
		EP 1 156 324	11/21/2001	Tokunaga et al.		
		EP 1 225 448	07/24/2002	McAleer et al.		
		EP 1 235 069 A1	08/28/2002	Nakaminami et		
		EP 1 256 798	11/13/2002	Miyazaki et al.		
	_	EP 1 275 732	01/15/2003	Charlton		
		EP 1 281 955	02/05/2003	Matsushita		

Examiner Signature	Date Considered	

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Complete if Known Substitute for form 1449A/PTO 10/688,312 **Application Number** INFORMATION DISCLOSURE Filing Date October 17, 2003 STATEMENT BY APPLICANT First Named Inventor David W. BURKE Group Art Unit 1743 (use as many sheets as necessary) **Examiner Name** Sheet 10 of **Attorney Docket Number** 7404-554

Examiner	Cite	Document Number	Publication Date	Name of Patentee or	Pages, Columns, Lines where Relevant Passages or Relevant
Initials*	No.1	Number-Kind Code ² (If known)	MM-DD-YYYY	Application of Cited Document	Figures Appear
		5,385,846	01/31/1995	Kuhn et al.	
		5,389,215	02/14/1995	Horiuchi et al.	
		5,395,504	03/07/1995	Saurer et al.	
		5,405,511	04/11/1995	Brown et al.	
		5,411,647	05/02/1995	Johnson et al.	
		5,413,690	05/09/1995	Kost et al.	
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		5,418,142	05/23/1995	Kiser et al.	
		5,421,189	06/06/1995	Dussault	
_		5,424,035	06/13/1995	Hones et al.	
		5,426,032	06/20/1995	Phillips et al.	
		5,437,772	08/01/1995	De Castro et al.	-
		5,437,999	08/01/1995	Diebold et al.	
		5,438,271	08/01/1995	White et al.	
		5,439,826	08/08/1995	Kontorovich	
		5,445,967	08/29/1995	Deuter	
		5,447,837	09/05/1995	Urnovitz	
		5,453,360	09/26/1995	Yu	

Examiner	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	T ⁶
Initials*	No. Country Code ³ -Number ⁴ -Kind Code ⁸ (if k		MM-DD-YYYY	Document	Figures Appear	Ì
		EP 1 288 653 A1	03/05/2003	Roche		
-		EP 1 308 720 A1	07/05/2003	Watanabe et al.		
		EP 1 312 919 A2	05/21/2003	Kermani		
		EP 1 316 367	06/04/2003	Dick et al.		
		EP 1 318 396 A1	06/11/2003	Hasegawa et al.		
		EP 1 324 025 A2	07/02/2003	Kermani		
		EP 1 324 038	07/02/2003	Dick et al.		
		EP 1 327 881	07/16/2003	Hodges et al.		

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Cub aditud	e for form 1449A/P)TO		Complete if Known			
Substituti	e 101 101m 1449AVF	10		Application Number	10/688,312		
INF	ORMATION	DISC	CLOSURE	Filing Date	October 17, 2003		
STA	ATEMENT BY	Y AP	PLICANT	First Named Inventor	David W. BURKE		
			•	Group Art Unit	1743		
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Sheet	11	of	38	Attornev Docket Number	7404-554		

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Examiner	Cite	Document Number	Publication Date	Name of Patentee or	Pages, Columns, Lines where Relevant Passages or Relevant					
Initials*	No. ¹	Number-Kind Code ² (If known)	MM-DD-YYYY	Application of Cited Document	Figures Appear					
		5,469,846	11/28/1995	Khan						
		5,470,533	11/28/1995	Shindo et al.						
		5,477,326	12/19/1995	Dosmann						
		5,489,414	02/06/1996	Schreiber et al.						
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		5,504,011	04/02/1996	Gavin et al.						
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		5,508,200	04/16/1996	Tiffany et al.						
		5,508,203	04/16/1996	Fuller et al.						
		5,509,410	04/23/1996	Hill et al.						
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		5,515,847	05/14/1996	Braig et al.						
		5,526,120	06/11/1996	Jina et al.						
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		5,532,128	07/02/1996	Eggers et al.						
		5,552,116	09/03/1996	Yokota et al.						

Examiner	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	7
Initials*	No.¹	Country Code ³ -Number ⁴ -Kind Code ⁶ (if known)	MM-DD-YYYY	Document	Figures Appear	`
		EP 1 352 611 A1	10/15/2003	Griffith et al.		
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	-	EP 1 369 684	12/10/2003	Arkray, Inc.		
		EP 1 369 687	12/10/2003	Miyamoto et al.		
		EP 1 394 535	03/03/2004	Davies et al.		
		EP 1 413 879	04/28/2004	Arkray, Inc.		
		EP 1 431 758 A1	06/23/2004	Arkray, Inc.		
		GB 2 295 676	06/05/1996	McNaughtan		

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Examiner Signature	Date Considered	

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Cubatitut	e for form 1449A/F	TO.		Complete if Known			
Substituti	8 101 101111 1449AVF	10		Application Number	10/688,312		
	ORMATION			Filing Date	October 17, 2003		
ST	ATEMENT BY	Y AP	PLICANT	First Named Inventor	David W. BURKE		
,		4		Group Art Unit	1743		
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Sheet	12	of	38	Attornev Docket Number	7404-554		

	U.S. PATENT DOCUMENTS									
Examiner Cite Initials* No.		Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear					
		5,554,531	09/10/1996	Zweig						
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		5,563,031	10/08/1996	Yu						
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		5,572,159	11/05/1996	McFarland						
		5,575,895	11/19/1996	Ikeda et al.						
		5,576,073	11/19/1996	Kickelhain						
		5,580,794	12/03/1996	Allen						
		5,582,697	12/10/1996	Ikeda et al.						
		5,593,390	01/14/1997	Castellano et al.						
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		5,594,906	01/14/1997	Holmes, II et al.						
		5,597,532	01/28/1997	Connolly						
		5,604,110	02/18/1997	Baker et al.						
		5,605,662	02/25/1997	Heller et al.						
		5,605,837	02/25/1997	Karimi et al.						

Examiner	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	T ⁰
Initials*	No.¹	Country Code ³ -Number ⁴ -Kind Code ⁸ (if known)	MM-DD-YYYY	Document	Figures Appear	
, i		GB 2 365 123	02/13/2002	Murdo		
		JP 91-59644	06/20/1997	Munakata		
		JP 93-312761	11/22/1993	Fukuda et al.		
	-	JP 01-291153	11/22/1989	Nankai et al.		
		JP 03-099254	04/24/1991	Ishihara		
		JP 04-121652	04/22/1992	Okuma		
		JP 08-262026	10/11/1996	Charlton et al.		
	_	JP 09-043242	02/14/1997	Nishimura		

Examiner Signature		Date Conside	red	

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Subatitud	te for form 1449A/F	TO.		Complete if Known			
Substitut	e ioi ioiiii 1449AVF	10		Application Number	10/688,312		
INF	ORMATION	DISC	CLOSURE	Filing Date	October 17, 2003		
ST	STATEMENT BY APPLICANT			First Named Inventor	David W. BURKE		
,	· · · · · · · · · · · · · · · · · · ·	4		Group Art Unit	1743		
(use as many shee	ts as r	ecessary)	Examiner Name			
Sheet	13	of	38	Attornev Docket Number	7404-554		

_	U.S. PATENT DOCUMENTS							
Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear			
		5,611,900	03/18/1997	Worden et al.				
1		5,620,579	04/15/1997	Genshaw et al.				
		5,620,863	04/15/1997	Tomasco et al.				
-	_	5,628,890	05/13/1997	Carter et al.				
		5,630,986	05/20/1997	Charlton et al.				
-		5,635,362	06/03/1997	Levine et al.				
		5,635,364	06/03/1997	Clark et al.				
		5,639,671	06/17/1997	Bogart et al.				
		5,642,734	07/01/1997	Ruben et al.				
		5,645,798	07/08/1997	Schreiber et al.				
		5,650,061	07/22/1997	Kuhr et al.				
		5,650,062	07/22/1997	Ikeda et al.				
		5,653,863	08/05/1997	Genshaw et al.				
		5,654,178	08/05/1997	Fitzpatrick et al.				
		5,656,502	08/12/1997	MacKay et al.				
		5,658,443	08/19/1997	Yamamoto et al.				
		5,658,802	08/19/1997	Hayes et al.				
		5,665,215	09/09/1997	Bussmann et al.				

Examiner	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	7
Initials*	No.1	Country Code ³ -Number ⁴ -Kind Code ⁶ (if known)	MM-DD-YYYY	Document	Figures Appear	
		JP 10 332626	12/18/1998	NOK		
		JP 2000-19146	01/21/2000	Miyashita et al.		
		JP 2000 019147	01/21/2000	NOK		
		JP 63-111,453	05/16/1988	Nakajima et al.		
		JP 63-128,252	05/31/1988	Kawaguri et al.		
		RU 2180514	03/20/2002	Shmelev et al.		
		WO 81/01794	07/09/1981	Ash et al.		
		WO 83/00926	03/17/1983	Clark		

Examiner Signature	Date Considered	

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2		NTO		Complete if Known				
Substitut	e for form 1449A/F	10		Application Number	10/688,312			
INF	ORMATION	DISC	LOSURE	Filing Date	October 17, 2003			
ST	ATEMENT B	Y AP	PLICANT	First Named Inventor	David W. BURKE			
				Group Art Unit	1743			
(use as many shee	ts as n	ecessary)	Examiner Name				
Sheet	14	of	38	Attornev Docket Number	7404-554			

U.S. PATENT DOCUMENTS								
Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear			
<u>-</u>		5,670,031	09/23/1997	Hintsche et al.				
	-	5,682,884	11/04/1997	Hill et al.				
-		5,686,659	11/11/1997	Neel et al.				
		5,691,486	11/25/1997	Behringer et al.				
		5,691,633	11/25/1997	Liu et al.				
		5,695,623	12/09/1997	Michel et al.				
		5,698,083	12/16/1997	Glass				
	-	5,700,695	12/23/1997	Yassinzadeh et al.				
		5,708,247	01/13/1998	McAleer et al.				
		5,710,622	01/20/1998	Neel et al.				
		5,719,667	02/17/1998	Miers				
		5,720,862	02/24/1998	Hamamoto et al.				
		5,723,284	03/03/1998	Ye				
		5,727,548	03/17/1998	Hill et al.				
		5,728,074	03/17/1998	Castellano et al.				
		5,745,308	04/28/1998	Spangenberg				
		5,757,666	05/26/1998	Schreiber et al.				
		5,759,794	06/02/1998	Levine et al.				

Examiner Cit		Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	T⁴
Initials*	No.1	Country Code ³ -Number ⁴ -Kind Code ⁶ (if known)	MM-DD-YYYY	Document	Figures Appear	
	-	WO 86/07632	12/31/1986	Nankai et al.		
		WO 89/08713	09/21/1989	Pottgenea		
		WO 89/09397	10/05/1989	Nankai et al.		
		WO 90/05293	05/17/1990	Michel		
		WO 92/01928	02/06/1992	Cozzette et al.		
		WO 92/07655	05/14/1992	Cox et al.		
		WO 92/15859	09/17/1992	Adrian et al.		
		WO 92/15861	09/17/1992	Grant et al.		

Examiner Signature	Date Considered	

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Cubatitus	. for form 4.440.0 /D	170		Complete if Known			
Substitute	e for form 1449A/P	10		Application Number	10/688,312		
	ORMATION I			Filing Date	October 17, 2003		
STA	ATEMENT BY	Y AP	PLICANT	First Named Inventor	David W. BURKE		
				Group Art Unit	1743		
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Sheet	15	of	38	Attornev Docket Number	7404-554		

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Initials*	No. ¹	Number-Kind Code ² (If known)	MM-DD-YYYY	Application of Cited Document	Figures Appear			
		5,762,770	06/09/1998	Pritchard et al.				
		5,776,710	07/07/1998	Levine et al.				
		5,780,304	07/14/1998	Matzinger et al.				
		5,786,584	07/28/1998	Button et al.				
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		5,837,546	11/17/1998	Allen et al.				
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Examiner	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	T ⁶
Initials*	No.¹	Country Code ³ -Number ⁴ -Kind Code ⁶ (if known)	MM-DD-YYYY	Document	Figures Appear	
		WO 92/15950	09/17/1992	Arbuckle et al.		
		WO 92/22669	12/23/1992	Gullick		
		WO 93/09433	05/13/1993	Gharib		
	_	WO 94/12950	06/09/1994	Holmes et al.		
		WO 94/16095	07/21/1994	Zweig		
		WO 94/23295	10/13/1994	McAleer et al.		
.		WO 94/28414	12/08/1994	Athey et al.		
_		WO 94/29705	12/22/1994	White et al.		

Examiner Signature	Date Considered	

EXAMINEK: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation it not in conformance and not considered. Included copy of this form with next communication to applicant.

Applicant's unique citation designation number (optional). ¹ See Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the emperor must precede the serial number of the patent document. ³ Kind of document by the apopropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. ⁶ Applicant is to place a check mark here if English language Translation is attached.

Substitut	e for form 1449A/F	OTO.		Complete if Known				
Gubstitut	e 101 101111 1443747	10		Application Number	10/688,312			
	ORMATION	_		Filing Date	October 17, 2003			
STA	ATEMENT BY	Y AP	PLICANT	First Named Inventor	David W. BURKE			
,		4		Group Art Unit	1743			
(use as many shee	ıs as n	ecessary)	Examiner Name				
Sheet	16	of	38	Attornev Docket Number	7404-554			

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Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear			
		5,856,195	01/05/1999	Charlton et al.				
		5,873,990	02/23/1999	Wojciechowski et al.				
-		5,883,378	03/16/1999	Irish et al.				
·		5,885,839	03/23/1999	Lingane et al.				
	-	5,890,489	04/06/1999	Elden				
		5,904,898	05/18/1999	Markart				
		5,911,872	06/15/1999	Lewis et al.				
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		5,948,289	09/07/1999	Noda et al.				
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		5,965,380	10/12/1999	Heller				
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Examiner	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	T ⁶
Initials*	No.¹	Country Code ³ -Number ⁴ -Kind Code ⁶ (if known)	MM-DD-YYYY	Document	Figures Appear	
		WO 95/03542	02/02/1995	Scott et al.		
		WO 95/06919	03/09/1995	Collins et al.		
		WO 95/07050	03/16/1995	Lennert et al.		
		WO 95/22597	08/24/1995	Diebold et al.		
		WO 96/04398	02/15/1996	Sanghera et al.		
		WO 96/07908	03/14/1996	Matzinger et al.		
		WO 96/13707	05/09/1996	Connolly		
		WO 96/15454	05/23/1996	Braach-		

Examiner Signature	Date Considered	

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Applicant's unique citation designation number (optional). ² See Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the emperor must precede the serial number of the patent document. ⁵ Kind of document by the apopropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. ⁶ Applicant is to place a check mark the patent document by the apopropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. ⁶ Applicant is to place a check mark here if English language Translation is attached.

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Substitu	ute for form 1449A/F	10		Application Number	10/688,312			
IN	FORMATION	DISC	LOSURE	Filing Date	October 17, 2003			
ST	TATEMENT B	Y AP	PLICANT	First Named Inventor	David W. BURKE			
				Group Art Unit	1743			
	(use as many shee	ts as r	ecessary)	Examiner Name				
Sheet	17	of	38	Attornev Docket Number	7404-554			

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Examiner Cite Document Number			Publication Date	Name of Patentee or	Pages, Columns, Lines where Relevant Passages or Relevant			
Initials*	No. ¹	Number-Kind Code ² (If known)	MM-DD-YYYY	Application of Cited Document	Figures Appear			
		5,989,917	11/23/1999	McAleer et al.				
		5,997,817	12/07/1999	Crismore et al.				
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····		6,126,609	10/03/2000	Keith et al.				
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Examiner	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	Τ⁴
Initials* No.1		Country Code ³ -Number ⁴ -Kind Code ⁶ (if known)	MM-DD-YYYY	Document	Figures Appear	
		WO 96/33403	10/24/1996	Higson		
	-	WO 97/00441	01/03/1997	Hodges et al.		
		WO 97/02487	01/23/1997	Pritchard et al.		
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		WO 97/16726	05/09/1997	Sullivan		
		WO 97/18465	05/22/1997	Hodges et al.		
		WO 97/29366	08/14/1997	Braach-		
		WO 97/29847	08/21/1997	McAleer et al.		

i	Date	
Examiner Signature	 Considered	

EXAMINEK: Initial II reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation it not in conformance and not considered. Include copy of this form with next communication to applicant.

Applicant's unique citation designation number (optional). ² See Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the emperor must precede the serial number of the patent document. ³ Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. ⁶ Applicant is to place a check mark here if English language Translation is attached.

				Complete if Known				
Substitute fo	or form 1449A	VPTO		Application Number	10/688,312			
INFO	RMATION	I DISCI	LOSURE	Filing Date	October 17, 2003			
STAT	TEMENT E	BY APF	PLICANT	First Named Inventor	David W. BURKE			
				Group Art Unit	1743			
(use as many sheets as necessary)				Examiner Name				
Sheet	18	of	38	Attornev Docket Number	7404-554			

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Examiner Cite Initials* No.		Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear				
		6,129,823	10/10/2000	Hughes et al.					
		6,134,461	10/17/2000	Say et al.					
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Examiner	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	T ⁴
Initials* No.1		Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	MM-DD-TTTT	Document	Figures Appear	
		WO 97/30344	08/21/1997	McAleer et al.		
		WO 97/39341	10/29/1997	Fuller et al.		
	_	WO 97/39343	10/23/1997	Garnham et al.		
		WO 97/42882	11/20/1997	Douglas et al.		
		WO 97/42888	11/20/1997	Douglas et al.		<u> </u>
		WO 97/45719	12/04/1997	Kessler		$oldsymbol{ol}}}}}}}}}}}}}}}}}}$
		WO 98/05424	02/12/1998	Chow		$oldsymbol{ol}}}}}}}}}}}}}}}}}$
		WO 98/19153	05/07/1998	Vadgama et al.		

Examiner Date Considered			
	Examiner Signature		

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Substitute for form 1449A/PTO				Complete if Known				
Substituti	5 101 101111 1449AVP	10		Application Number	10/688,312			
	ORMATION			Filing Date	October 17, 2003			
STA	STATEMENT BY APPLICANT			First Named Inventor	David W. BURKE			
4.		4		Group Art Unit	1743			
(use as many sheets as necessary)			ecessary)	Examiner Name				
Sheet	19	of	38	Attornev Docket Number	7404-554			

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Examiner	Cite	Document Number	Publication Date	Name of Patentee or	Pages, Columns, Lines where Relevant Passages or Relevant				
Initials*	No. ¹	Number-Kind Code ² (if known)	MM-DD-YYYY	Application of Cited Document	Figures Appear				
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		6,174,420	01/16/2001	Hodges et al.					
-		6,175,752	01/16/2001	Say et al.					
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Examiner Cite		Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	т
initials*	No.¹	Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	MM-DD-YYYY	Document	Figures Appear	
		WO 98/19159	05/07/1998	Douglas et al.		
		WO 98/29740	07/09/1998	Clerc et al.		
		WO 98/35225	08/13/1998	Heller et al.		
		WO 98/55853	12/10/1998	Altin et al.		
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		WO 99/05516	04/02/1999	Kawanaka et al.		
		WO 99/05966	02/11/1999	Alton et al.		
		WO 99/09404	02/25/1999	Maxwell et al.		

Examiner Signature		Date Considered	

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		170	 -	Complete if Known				
Substitute to	or form 1449A/F	P10		Application Number	10/688,312			
INFO	RMATION	DISCL	.OSURE	Filing Date	October 17, 2003			
STAT	STATEMENT BY APPLICANT			First Named Inventor	David W. BURKE			
				Group Art Unit	1743			
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Sheet	20	of	38	Attornev Docket Number	7404-554			

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Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear			
		6,246,330	06/12/2001	Nielsen				
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	_	6,251,260	06/26/2001	Heller et al.				
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Examiner	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	T ⁴
Initials*	No.1	Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	MM-DD-YYYY	Document	Figures Appear	
		WO 99/12008	03/11/1999	Zweig et al.		
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	1.2.2	WO 99/13100	03/18/1999	Forrow et al.		
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		WO 99/23479	05/14/1999	Weitman et al.		
-		WO 99/29230	06/17/1999	Bonnecaze et		
		WO 99/30152	06/17/1999	Crismore et al.		

Examiner Signature	Date Considered	

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Substitute for form 1449A/PTO				Complete if Known				
Substitute	101 101111 1449/0	FIO		Application Number	10/688,312			
	ORMATION			Filing Date	October 17, 2003			
STA	TEMENT B	Y API	PLICANT	First Named Inventor	David W. BURKE	. 		
				Group Art Unit	1743			
(use as many sheets as necessary)			ecessary)	Examiner Name				
Sheet	21	of	38	Attornev Docket Number	7404-554			

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Examiner Initials*			Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear
		6,284,550	09/04/2001	Carroll et al.	
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	·	6,315,951	11/13/2001	Markart	
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Examiner Cite		Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	Τŧ
Initials*	No.¹	Country Code ³ -Number ⁴ -Kind Code ⁶ (if known)	MM-DD-YYYY	Document	Figures Appear	
		WO 99/32881	07/01/1999	Beaty et al.		
		WO 99/39627	08/12/1999	Elden et al.		
		WO 99/41596	08/19/1999	Sumegi et al.	-	
		WO 99/51974	10/14/1999	Ikeda et al.		
		WO 99/57317	11/11/1999	Bamdad et al.		
		WO 99/58709	11/18/1999	Stewart et al.		
		WO 99/59464	11/25/1999	Khalil et al.		
		WO 99/60383	11/25/1999	Szmacinski		

Examiner Signature	Date Considered	

EXAMINEK: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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Substitute for form 1449A/PTO				Complete if Known	
Substitute	: 101 101111 144 <i>92</i> 01	-10		Application Number	10/688,312
	ORMATION			Filing Date	October 17, 2003
STA	ATEMENT B	Y AP	PLICANT	First Named Inventor	David W. BURKE
4.		4		Group Art Unit	1743
(L	ise as many shee	ts as ne	ecessary)	Examiner Name	
Sheet	22	of	38	Attornev Docket Number	7404-554

		-	U.S. PATEN	T DOCUMENTS	
Examiner Initials*	Cite No.1	Document Number	Publication Date	Name of Patentee or	Pages, Columns, Lines where Relevant Passages or Relevant
initials*	No.	Number-Kind Code ² (If known)	MM-DD-YYYY	Application of Cited Document	Figures Appear
		6,325,917	12/04/2001	Maxwell et al.	
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Examiner	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	7
Initials*	No.¹	Country Code ³ -Number ⁴ -Kind Code ⁸ (if known)	MM-DD-YYYY	Document	Figures Appear	
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		WO 00/26638	05/11/2000	Lewis		
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		WO 00/33072	06/08/2000	Deweese et al.		
		WO 00/33074	06/08/2000	Lewis et al.		

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¹ Applicant's unique citation designation number (optional). ² See Kinds Codes of USPTO Patent Documents at www.uspto.gov or MPEP 901.04. ³ Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). ⁴ For Japanese patent documents, the indication of the year of the reign of the emperor must precede the serial number of the patent document. ³ Kind of document by the apopropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. ⁶ Applicant is to place a check mark here if English language Translation is attached.

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Substituti	e for form 1449AVP	10		Application Number	10/688,312	
INF	ORMATION	DISC	LOSURE	Filing Date	October 17, 2003	
STA	ATEMENT BY	Y AP	PLICANT	First Named Inventor	David W. BURKE	
,				Group Art Unit	1743	
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Sheet	23	of	38	Attornev Docket Number	7404-554	

Examiner	Cite	Document Number	Publication Date	Name of Patentee or	Pages, Columns, Lines where
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Initials*	No.'	Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	MM-DD-YYYY	Document	Figures Appear	
		WO 00/42422	07/20/2000	McAleer et al.		
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Substitute to	or form 1449A/P	10		Application Number	10/688,312	
INFO	RMATION I	DISC	LOSURE	Filing Date	October 17, 2003	
STAT	EMENT BY	/ AP	PLICANT	First Named Inventor	David W. BURKE	
,				Group Art Unit	1743	
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Sheet	24	of	38	Attornev Docket Number	7404-554	

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Initials*	No. ¹	Number-Kind Code ² (If known)	MM-DD-YYYY	Application of Cited Document	Figures Appear
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		WO 00/78917 A1	12/28/2000	Lea		
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Complete if Known Substitute for form 1449A/PTO 10/688,312 **Application Number** INFORMATION DISCLOSURE October 17, 2003 Filing Date STATEMENT BY APPLICANT David W. BURKE First Named Inventor 1743 **Group Art Unit** (use as many sheets as necessary) **Examiner Name** Attorney Docket Number 7404-554 25 of Sheet

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Examiner Cite Initials* No.1		Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear			
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Examiner	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	T ⁶
Initials*	No.¹	Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	MM-DD-YYYY	Document	Figures Appear	<u> </u>
		WO 01/30915	05/03/2001	Zheng et al.		<u> </u>
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Substitute f	or form 1449A	/PTO		Application Number	10/688,312		
INFO	RMATION	DISC	LOSURE	Filing Date	October 17, 2003		
STAT	FEMENT 	BY APF	PLICANT	First Named Inventor	David W. BURKE		
				Group Art Unit	1743		
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Sheet	26	of	38	Attornev Docket Number	7404-554		

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Examiner Cite Initials* No.1		Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear		
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Initials*	No.1	Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	MM-DD-YYYY	Document	Figures Appear	
		WO 01/57239	08/09/2001	Yani et al.		
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Substitute fo	or form 1449A/	/PTO		Application Number	10/688,312		
INFO!	RMATION	DISC	LOSURE	Filing Date	October 17, 2003		
STAT	EMENT B	BY AP	PLICANT	First Named Inventor	David W. BURKE		
				Group Art Unit	1743		
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Sheet	27	of	38	Attornev Docket Number	7404-554		

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Examiner Cite Initials* No.1		Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear		
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Initials*	No.1	Country Code ³ -Number ⁴ -Kind Code ⁵ (if known)	MM-DD-YYYY	Document	Figures Appear	ـــــ
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· · · · · ·		WO 01/74242	10/11/2001	Shartle		$oldsymbol{ol}}}}}}}}}}}}}}}}}}$
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INF	ORMATION	DISC	LOSURE	Filing Date	October 17, 2003		
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				Group Art Unit	1743		
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Substitute to	or form 1449A	PIO		Application Number	10/688,312		
INFO	RMATION	I DISCI	OSURE	Filing Date	October 17, 2003		
STAT	EMENT E	BY APP	LICANT	First Named Inventor	David W. BURKE		
				Group Art Unit	1743		
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Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear
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		WO 02/078512 A2	10/10/2002	Drucker et al.		
		WO 02/078533	10/10/2002	Moerman et al.		<u> </u>
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		WO 02/086483	10/31/2002	Tokunaga et al.		
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		WO 02/097418	12/05/2002	Taniike et al.		

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Complete if Known Substitute for form 1449A/PTO 10/688,312 **Application Number** INFORMATION DISCLOSURE Filing Date October 17, 2003 STATEMENT BY APPLICANT David W. BURKE **First Named Inventor** 1743 Group Art Unit (use as many sheets as necessary) **Examiner Name** Attornev Docket Number 7404-554 Sheet of

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Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear
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Substitute			Application Number	10/688,312		
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STA	TEMENT B	Y AP	PLICANT	First Named Inventor	David W. BURKE	
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		WO 02/49507	06/27/2002	Stiene et al.		ļ
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···		WO 02/103343 A1	12/27/2002	Nakaminami et		
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.		WO 03/015627	02/27/2003	Moerman et al.		1

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Examiner Initials*	Cite No. ¹	Document Number Number-Kind Code ² (If known)	Publication Date MM-DD-YYYY	Name of Patentee or Application of Cited Document	Pages, Columns, Lines where Relevant Passages or Relevant Figures Appear
		2004 0005721	01/08/2004	Tanike et al.	
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Examiner	Cite	Foreign Patent Document	Publication Date	Name of Patentee or Application of Cited	Pages, Columns, Lines, Where Relevant Passages or Relevant	⊤ ⁴
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		WO 03/015629	02/27/2003	Moerman et al.		<u> </u>
		WO 03/021706 A1	03/13/2003	Higuchi et al.		
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		OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS	
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Substitute	e for form 1449B/P	PIO		Application Number	10/688,312		
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		OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS	
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Substitute	e for form 1449B/	ыо		Application Number	10/688,312		
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STA	ATEMENT B	Y AP	PLICANT	First Named Inventor	David W. BURKE		
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EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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STAT	EMENT E	BY APPL	LICANT	First Named Inventor	David W. BURKE	
				Group Art Unit	1743	
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Sheet	38	of	38	Attorney Docket Number	7404-554	

of the article (when appropriate), title of the item (book, magazine, journal, ume-issue number(s) publisher city and/or country where published
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